

# **MOSFET** - Power, Single **N-Channel**

80 V, 1.1 mΩ, 335 A

# NTMTS1D2N08H

#### **Features**

- Small Footprint (8x8 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- These Devices are Pb-Free and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	80	V
Gate-to-Source Voltage	€		$V_{GS}$	±20	V
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	335	Α
Current R <sub>0JC</sub> (Notes 1, 3)	Steady	T <sub>C</sub> = 100°C		237	
Power Dissipation	State	T <sub>C</sub> = 25°C	$P_{D}$	300	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C		150	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	41	Α
Current R <sub>θJA</sub> (Notes 1, 2, 3)	Steady	T <sub>A</sub> = 100°C		29	
Power Dissipation	State	State T <sub>A</sub> = 25°C		5	W
R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C		2.5	
Pulsed Drain Current	$T_A = 25$	$T_A = 25^{\circ}C, t_p = 10 \mu s$		900	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
Source Current (Body Diode)			I <sub>S</sub>	335	Α
Single Pulse Drain-to-Source Avalanche Energy (L = 3 mH, I <sub>L(pk)</sub> = 34 A)			E <sub>AS</sub>	1734	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

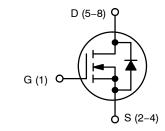
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL RESISTANCE MAXIMUM RATINGS

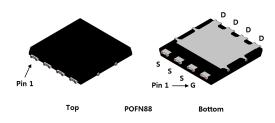
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.5	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	30	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
80 V	1.1 mΩ @ 10 V	335 A



**N-CHANNEL MOSFET** 



DFNW8 CASE 507AP

#### **MARKING DIAGRAM**



= Assembly Location WL = 2-digit Wafer Lot Code

Y = Year Code WW = Work Week Code

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

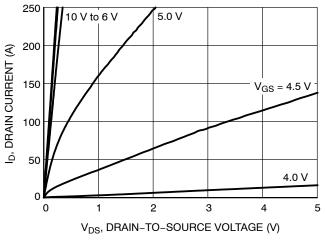
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS								
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		80			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				57		mV/°C	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25 °C			10		
		$V_{DS} = 80 \text{ V}$	T <sub>J</sub> = 125°C			250	μΑ	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{G}$	<sub>S</sub> = 20 V			100	nA	
ON CHARACTERISTICS (Note 4)								
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 590 μΑ	2.0	2.9	4.0	V	
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-7.6		mV/°C	
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 90 A		0.93	1.1		
		V <sub>GS</sub> = 6 V	I <sub>D</sub> = 59 A		1.28	1.6	mΩ	
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> =15 V, I <sub>D</sub> = 90 A			400		S	
CHARGES, CAPACITANCES & GATE RE	SISTANCE							
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 500 kHz, V <sub>DS</sub> = 40 V			10100		pF	
Output Capacitance	Coss				1455			
Reverse Transfer Capacitance	C <sub>RSS</sub>				43			
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 64 V; I <sub>D</sub> = 90 A			147		nC	
Threshold Gate Charge	Q <sub>G(TH)</sub>				27			
Gate-to-Source Charge	Q <sub>GS</sub>				41			
Gate-to-Drain Charge	$Q_GD$				32			
Plateau Voltage	$V_{GP}$				4		V	
SWITCHING CHARACTERISTICS (Note	5)							
Turn-On Delay Time	t <sub>d(ON)</sub>				29			
Rise Time	t <sub>r</sub>	VGS = 10 V. Vr	ns = 64 V.		14		1	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 64 V, $I_{D}$ = 90 A, $R_{G}$ = 2.5 $\Omega$			66		ns	
Fall Time	t <sub>f</sub>				19			
DRAIN-SOURCE DIODE CHARACTERIS	STICS						•	
Forward Diode Voltage	$V_{SD}$	$V_{SD}$ $V_{GS} = 0 V$ , $T_{J} = 2$			0.8	1.2	.,	
		I <sub>S</sub> = 90 A	T <sub>J</sub> = 125°C		0.6			
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 90 \text{ A}$			84		ns	
Reverse Recovery Charge	Q <sub>RR</sub>				189		nC	

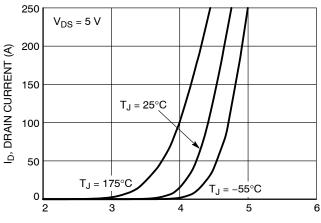
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**





V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V) Figure 2. Transfer Characteristics

Figure 1. On-Region Characteristics

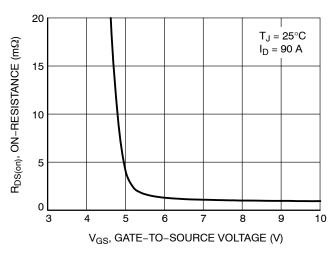


Figure 3. On-Resistance vs. Gate-to-Source Voltage

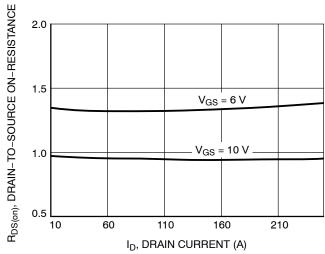


Figure 4. On-Resistance vs. Drain Current and **Gate Voltage** 

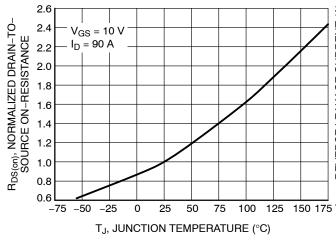


Figure 5. On-Resistance Variation with **Temperature** 

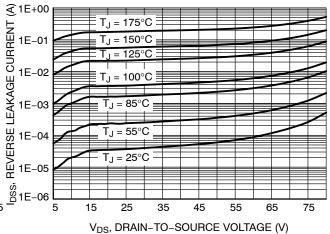


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

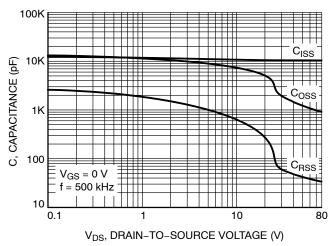


Figure 7. Capacitance Variation

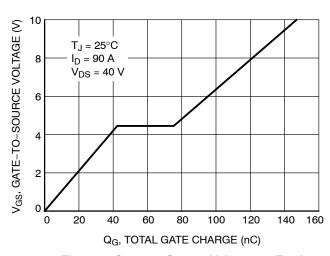


Figure 8. Gate-to-Source Voltage vs. Total Charge

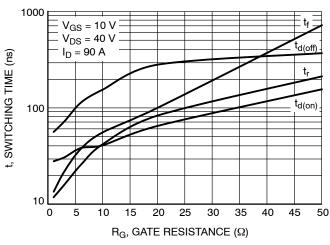


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

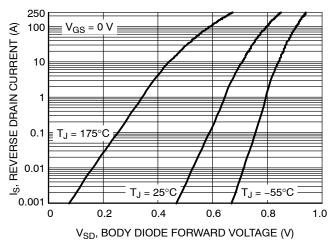


Figure 10. Diode Forward Voltage vs. Current

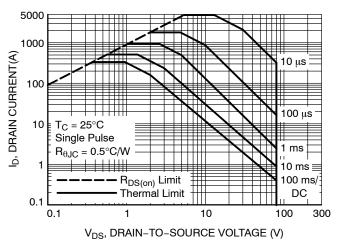


Figure 11. Maximum Rated Forward Biased Safe Operating Area

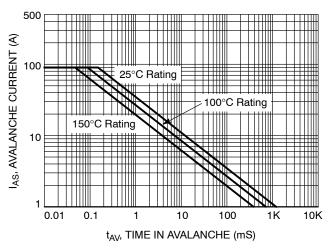
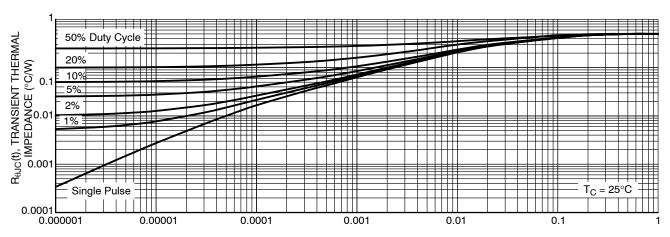


Figure 12. Maximum Drain Current vs. Time in Avalanche

# **TYPICAL CHARACTERISTICS**



t, RECTANGULAR PULSE DURATION (sec)

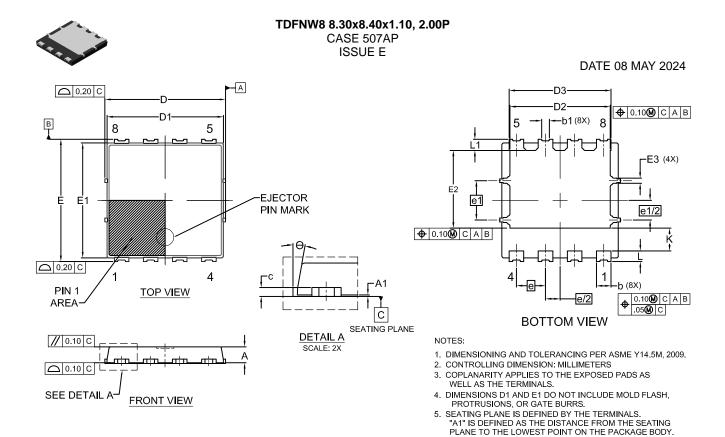
Figure 13. Thermal Response

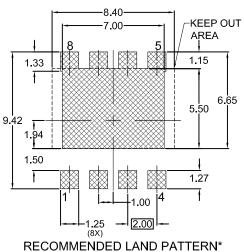
#### **DEVICE ORDERING INFORMATION**

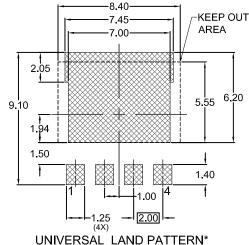
Device	Marking	Package	Shipping <sup>†</sup>
NTMTS1D2N08H	NTMTS1D2N08H	DFNW8 (Pb–Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.









ΟΙΜ	MILLIMETERS		
Di.v.	MIN.	MAX.	
Α	1.00	1.00 1.10 1	
A1	0.00		0.05
b	0.90	1.00	1.10
b1	0.35	0.45	0.55
С	0.23	0.28	0.33
О	8.20	8.30	8.40
D1	7.90	8.00	8.10
D2	6.80	6.90	7.00
D3	6.90	7.00	7.10
Е	8.30	8.40	8.50
E1	7.80	7.90	8.00
E2	5.24	5.34	5.44
E3	0.25	0.35	0.45
е		2.00 BS	С
e/2		1.00 BS	С
e1		2.70 BS	С
e1/2	1.35 BSC		
K	1.50	1.57	1.70
L	0.64	0.74	0.84
L1	0.67	0.77	0.87
θ	0°		12°

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE
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THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES
REFERENCE MANUAL, SOLDERRM/D.

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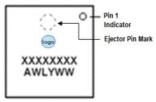
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CASE 507AP ISSUE E

**DATE 08 MAY 2024** 

# GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code
A = Assembly Location
WL = Wafer Lot Code
Y = Year Code
WW = Work Week Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.

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